MA2SP05

Silicon epitaxial planar type

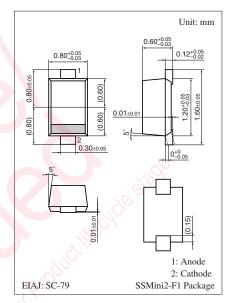
For high frequency attenuator

■ Features

- High performance forward current I_F controlled forward dynamic resistance r_f
- Small terminal capacitance C_t
- Miniature package and surface mounting type

■ Absolute Maximum Ratings $T_a = 25$ °C

| Parameter | Symbol | Rating | Unit |
|----------------------|------------------|-------------|------|
| Reverse voltage | V_R | 60 | V |
| Forward current | I_{F} | 50 | mA |
| Junction temperature | T_{j} | 150 | °C |
| Storage temperature | T _{stg} | -55 to +150 | °C |

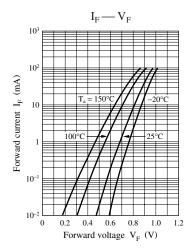


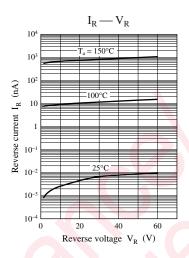
Marking Symbol: 6P

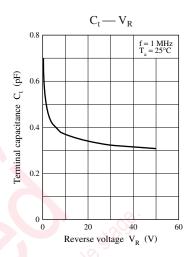
■ Electrical Characteristics T_a = 25°C ± 3°C

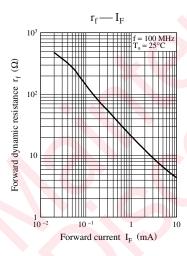
| Parameter | Symbol | Conditions | Min | Тур | Max | Unit |
|----------------------------|----------------|--|------|-----|-----|------|
| Forward voltage | $V_{\rm F}$ | $I_F = 10 \text{ mA}$ | 1.90 | | 1.0 | V |
| Reverse current | I _R | $V_R = 60 \text{ V}$ | | | 100 | nA |
| Terminal capacitance | C _t | $V_R = 0 \text{ V, } f = 1 \text{ MHz}$ | | | 2.4 | pF |
| Forward dynamic resistance | $r_{\rm f}$ | $I_F = 10 \text{ mA}, f = 100 \text{ MHz}$ | | | 5.5 | Ω |

Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 measuring methods for diodes.









2 SKL00012BED

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